

N-Channel 30-V (D-S) MOSFET

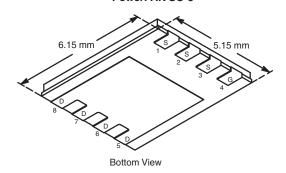
PRODUC	CT SUMMARY			
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^a	Q _g (Typ.)	
30	0.0032 at V _{GS} = 10 V	30	26.5 nC	
30	0.0039 at V _{GS} = 4.5 V	26.3	20.5 110	

FEATURES

- · Halogen-free
- TrenchFET® Power MOSFET
- 100 % R_g and UIS Tested

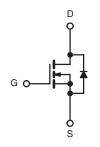


PowerPAK SO-8



APPLICATIONS

- DC/DC Conversion
 - Low-Side Switch
- Notebook PC
- Gaming



N-Channel MOSFET

ABSOLUTE MAXIMUM RATIN	IGS T _A = 25 °C,	unless othe	rwise noted		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V_{DS}	30	V	
Gate-Source Voltage		V_{GS}	± 20	V	
	T _C = 25 °C		30		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	I _D	22.6		
Continuous Diain Current (1) = 130 C)	T _A = 25 °C		21.5 ^{b, c}		
	T _A = 70 °C	1 1	17.1 ^{b, c}	^	
Pulsed Drain Current		I _{DM}	70	A	
Continuous Source-Drain Diode Current	T _C = 25 °C	I.	5.4		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	2.7 ^{b, c}		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	40		
Avalanche Energy		E _{AS}	80	mJ	
	T _C = 25 °C		6.0		
Maximum Power Dissipation	T _C = 70 °C	P _D	3.3	w	
waxiinuin rowei Dissipation	T _A = 25 °C	1 ^{FD}	3.0 ^{b, c}	VV	
	T _A = 70 °C	1 1	1.9 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RAT	INGS					
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R_{thJA}	33	42	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	16	21	C/ VV	

Notes:

- a. Based on T_C = 25 °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- $c_{1} t = 10 s$
- d. Maximum under Steady State conditions is 85 $^{\circ}\text{C/W}.$

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	30			٧
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 A		27		1406
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	- I _D = 250 μA		- 5.6		mv/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu\text{A}$	1.2		2.5	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zana Oaka Walkana Busin Oamani		V _{DS} = 30 V, V _{GS} = 0 V			1	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	μΑ
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α
	Б	V _{GS} = 10 V, I _D = 15 A		0.0026	0.0032	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 10 A		0.0032	0.0039	V mV/°(
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 15 A		75		S
Dynamic ^b						
Input Capacitance	C _{iss}			3545		
Output Capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		650		V mV/°C NA A A Ω Ω S S PF NC A V V
Reverse Transfer Capacitance	C _{rss}	1		240		
Total Cata Chausa	0	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$		62	95	
Total Gate Charge	Q _g			26.5	40	200
Gate-Source Charge	Q_{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		8.5		nc
Gate-Drain Charge	Q_{gd}			7.3		
Gate Resistance	R_g	f = 1 MHz	0.2	1.1	2.2	Ω
Turn-On Delay Time	t _{d(on)}			35	60	
Rise Time	t _r	V_{DD} = 15 V, R_{L} = 1.5 Ω		16	30	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		48	85	
Fall Time	t _f			16	30	no
Turn-On Delay Time	t _{d(on)}			18	35	115
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_{L} = 1.5 \Omega$		8	16	
Turn-Off Delay Time	t _{d(off)}	$V_{DD} = 15 \text{ V}, R_L = 1.5 \Omega$ 16 $I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$ 48 16 18		75		
Fall Time	t _f]		8	18	
Drain-Source Body Diode Characteristi	cs					
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			5.4	٨
Pulse Diode Forward Current ^a	I _{SM}				70	A
Body Diode Voltage	V_{SD}	I _S = 3 A		0.72	1.1	V
Body Diode Reverse Recovery Time	t _{rr}			33	65	ns
Body Diode Reverse Recovery Charge	Q_{rr}	I _F = 10 A, dl/dt = 100 A/μs, T _{.I} = 25 °C		27	54	nC
Reverse Recovery Fall Time t _a		$\frac{1}{1} = \frac{10}{10} \text{ A}, \text{ u/u} = \frac{100}{100} \text{ A/µs}, \frac{1}{1} = \frac{25}{100} = \frac{10}{100}$		17		
Reverse Recovery Rise Time	t _b	1		16		ns

Notes:

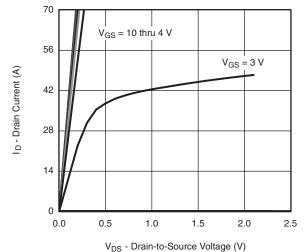
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%$

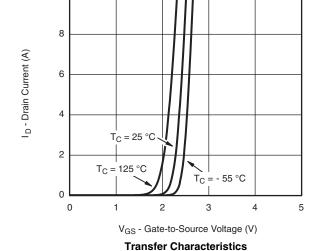
b. Guaranteed by design, not subject to production testing.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

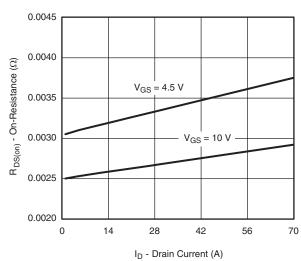


V_{DS} - Drain-to-Source voltage (v

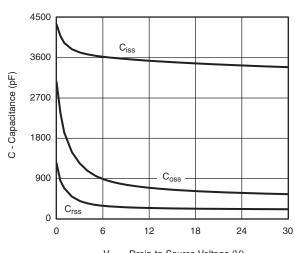


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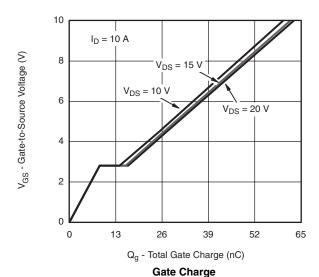


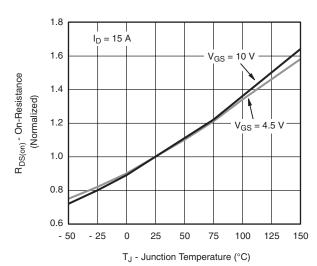


On-Resistance vs. Drain Current and Gate Voltage



 V_{DS} - Drain-to-Source Voltage (V) $\label{eq:capacitance}$

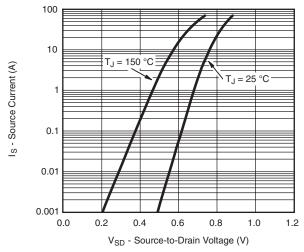




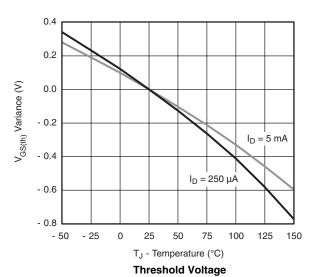
On-Resistance vs. Junction Temperature



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

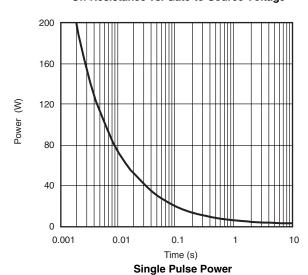


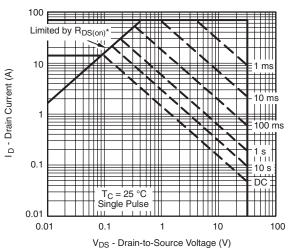
Source-Drain Diode Forward Voltage



0.025 $I_D = 15 A$ 0.020 $R_{DS(on)}$ - On-Resistance (Ω) 0.015 0.010 T_J = 125 °C 0.005 $T_J = 25$ °C 0.000 1 2 3 4 5 0 6 8 10

 V_{GS} - Gate-to-Source Voltage (V) On-Resistance vs. Gate-to-Source Voltage

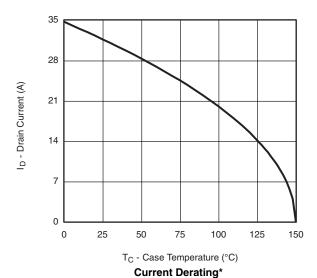


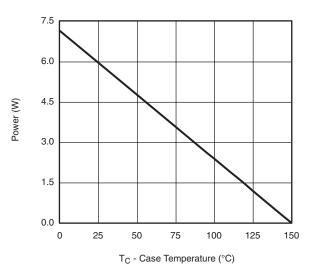


* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

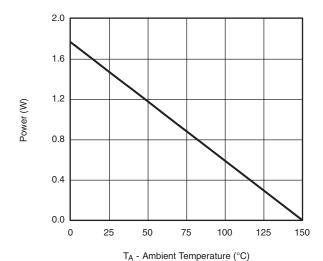
Safe Operating Area, Junction-to-Ambient

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





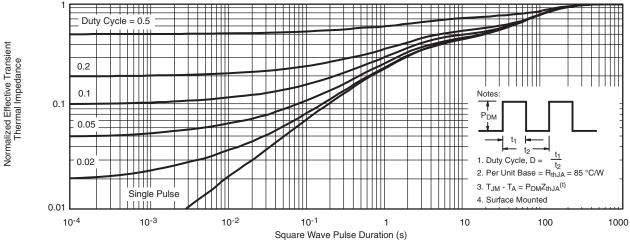
Power Derating, Junction-to-Foot



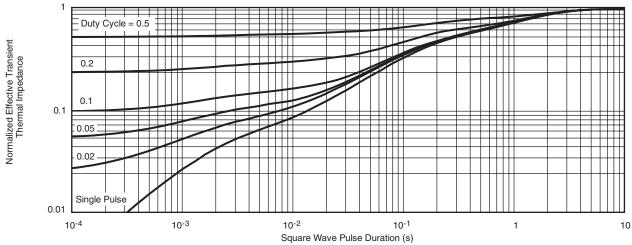
Power, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



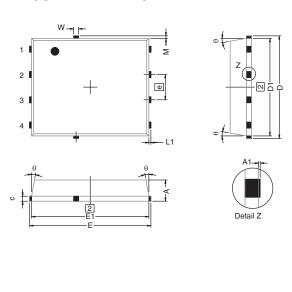
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

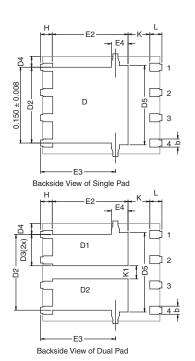


PowerPAK SO-8, (SINGLE/DUAL)



Notes

- 1. Inch will govern.
- 2 Dimensions exclusive of mold gate burrs.
- 3. Dimensions exclusive of mold flash and cutting burrs.



	MILLIMETERS			INCHES			
DIM.	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.97	1.04	1.12	0.038	0.041	0.044	
A1	0.00	-	0.05	0.000	-	0.002	
b	0.33	0.41	0.51	0.013	0.016	0.020	
С	0.23	0.28	0.33	0.009	0.011	0.013	
D	5.05	5.15	5.26	0.199	0.203	0.207	
D1	4.80	4.90	5.00	0.189	0.193	0.197	
D2	3.56	3.76	3.91	0.140	0.148	0.154	
D3	1.32	1.50	1.68	0.052	0.059	0.066	
D4	0.57 TYP.				0.0225 TYP.		
D5		3.98 TYP.		0.157 TYP.			
E	6.05	6.15	6.25	0.238	0.242	0.246	
E1	5.79	5.89	5.99	0.228	0.232	0.236	
E2	3.48	3.66	3.84	0.137	0.144	0.151	
E3	3.68	3.78	3.91	0.145	0.149	0.154	
E4		0.75 TYP.			0.030 TYP.		
е	1.27 BSC			0.050 BSC			
K		1.27 TYP.		0.050 TYP.			
K1	0.56	-	-	0.022	-	-	
Н	0.51	0.61	0.71	0.020	0.024	0.028	
L	0.51	0.61	0.71	0.020	0.024	0.028	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
θ	0°	-	12°	0°	-	12°	
W	0.15	0.25	0.36	0.006	0.010	0.014	
М	0.125 TYP.			0.005 TYP.			

DWG: 5881



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